

  
**ÖAW**  


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RD50 HV-CMOS Meeting

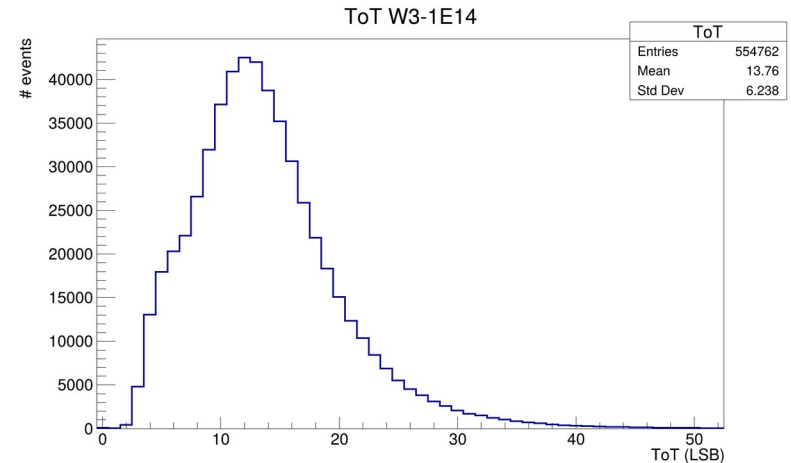
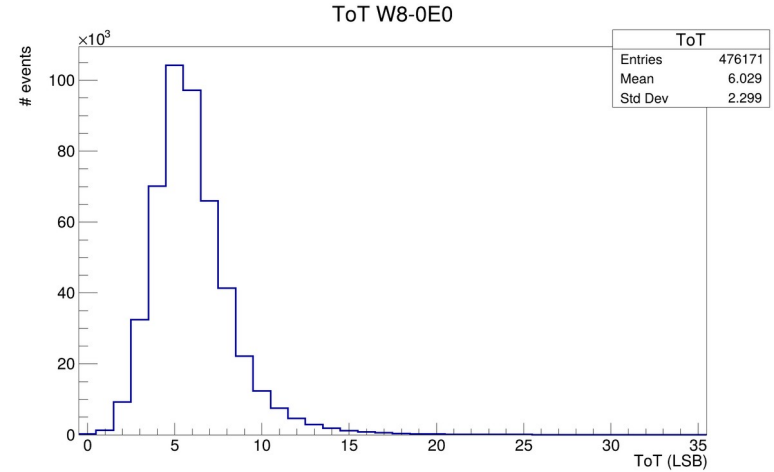
# DESY Test Beam Oct. 2024

## ToT and Calibration

**Bernhard Pils**

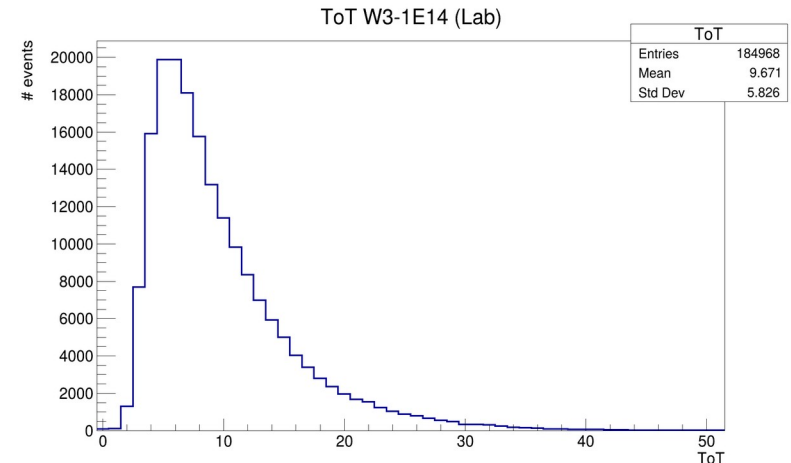
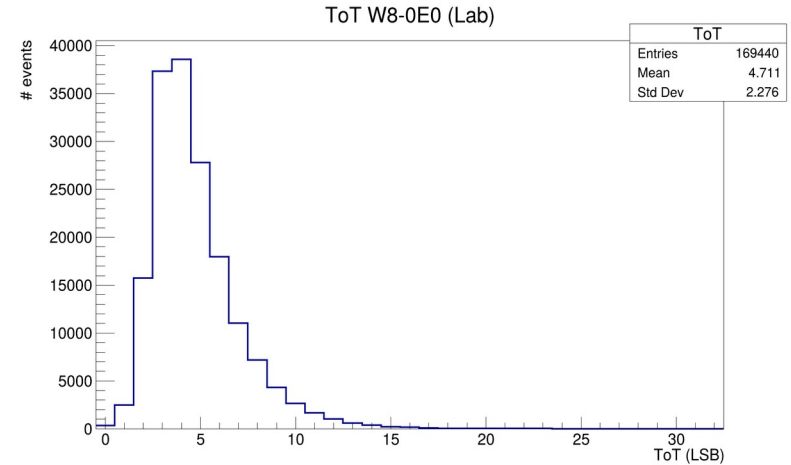
## Reminder

- Irradiated samples (1E14 and 3E14) showed larger ToT values than non-irradiated samples
- At same bias (-190V) and same threshold (1.1V)

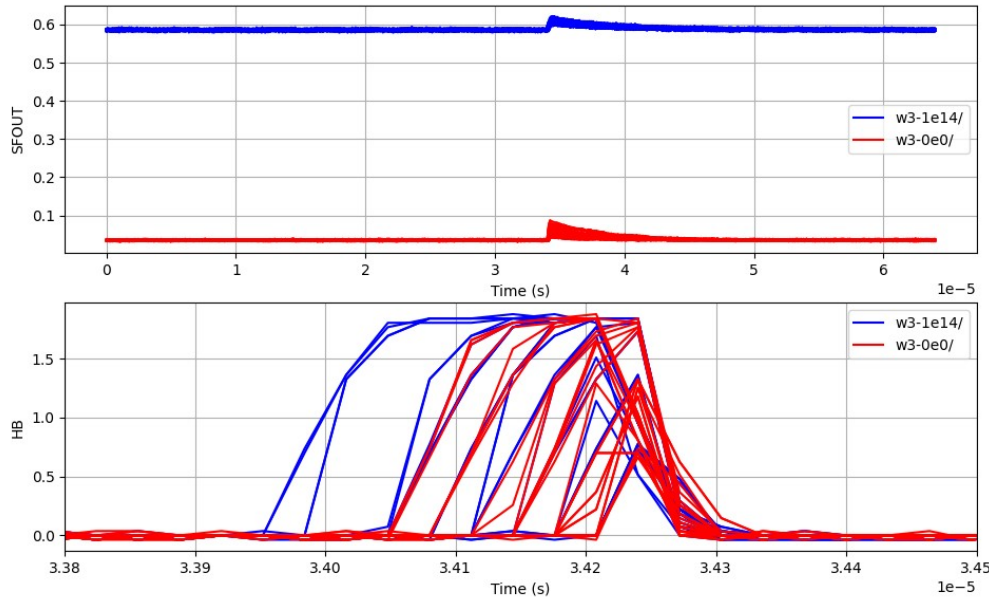


## Reproduce in Lab

- $^{90}\text{Sr}$  source used
- Same bias and threshold settings
- Same samples (but at room temperature)
- Digital data taking via EUDAQ
- Looking at SFOUT and HB of pixel 39:07
- Digital results:
  - Slightly smaller ToT compared to TB but also  $\text{ToT}(1\text{E}14) > \text{ToT}(0\text{E}0)$



## Analog Results

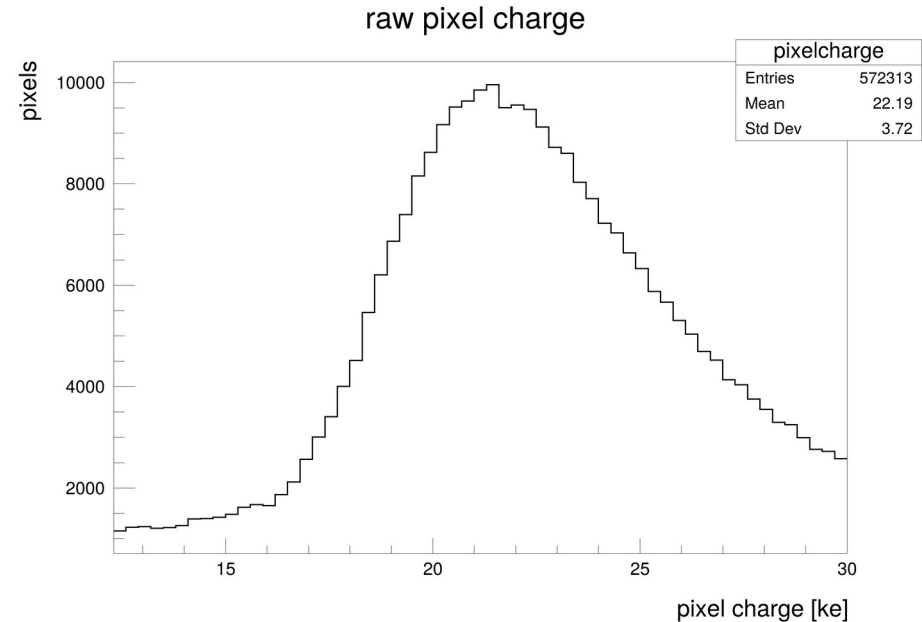


- HB signals of **1E14** longer than signals from **0E0** → digital behavior observed analog too
- SFOUT of **1E14** shows ~600 mV offset
  - Why?
  - Is radiation changing characteristics of transistors / bias voltages (VN could be off) ?

## Calibration of injection capacitors

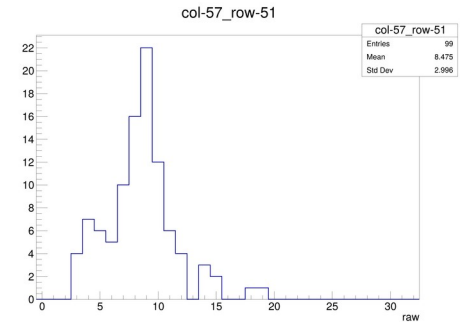
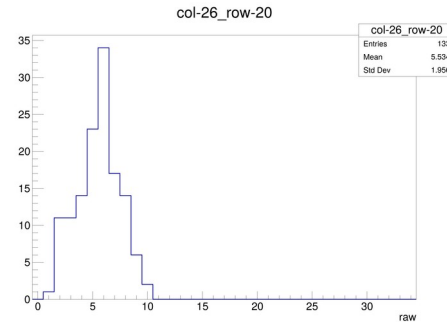
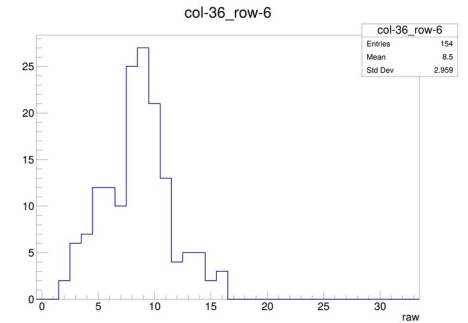
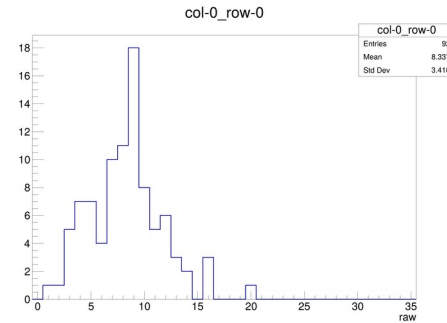
- MIP deposits  $\sim 22ke^-$  in  $280\mu m$  Si
- In fully depleted sensor full charge gets collected
- ToT of individual pixels at TB correspond to charge of MIP
  - Not quite right (more later)
- Evaluate injection capacitance for individual pixels by

$$Q_{MIP} = V_{inj, best} * C_{inj, calib}$$



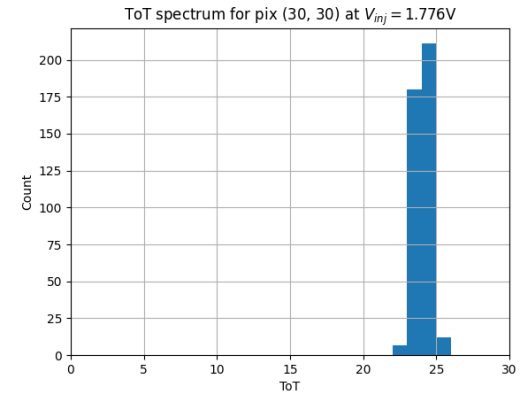
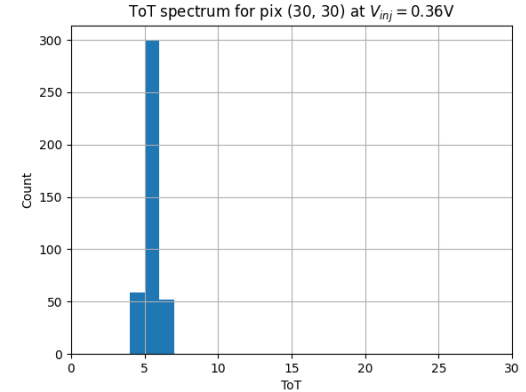
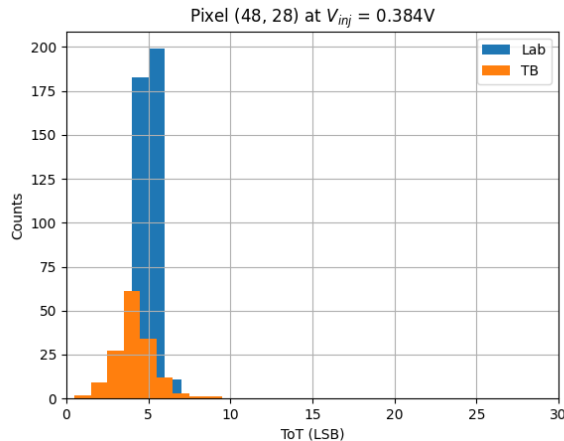
## ToT for individual pixels

- Getting proper statistics requires really long run
- Custom Corryvreckan extension to plot ToT histograms for individual pixels

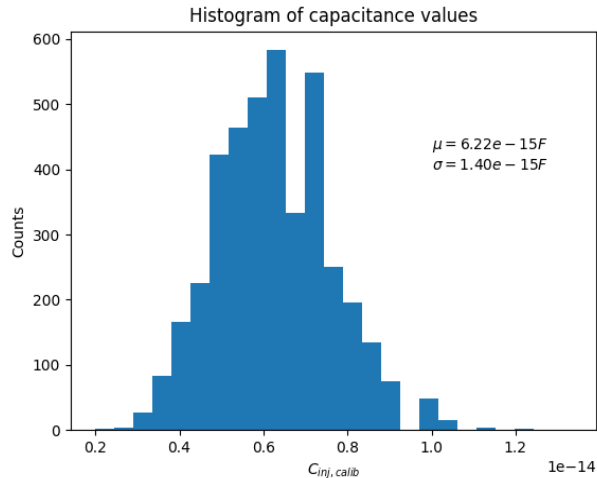
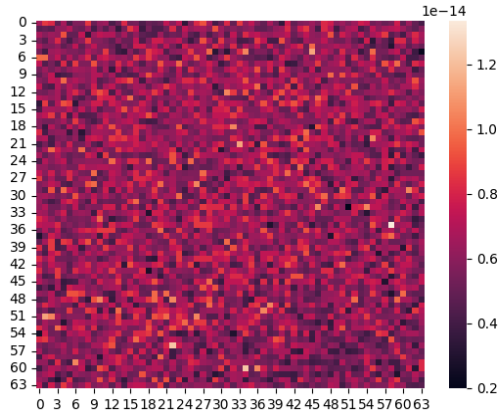


## ToT from injections

- Inject 500 times into all pixels for 75 steps in (0V, 1.8V)
- Try to find best match between ToT from testbeam and injections
  - $\rightarrow V_{inj, best}$  for best match
  - $C_{inj, calib} = Q_{MIP} / V_{inj, best}$



## Cap calibration for individual pixels



- **Mean of 6.2fF with Std. dev. of 1.4fF** evaluated
- Value in manual 2.8fF
- Problem:
  - In testbeam there is charge sharing:
  - Full MIP charge / ToT not only at one pixel but in cluster



## Cap calibration for clusters

- Can't be done for individual pixels
- Only possible for average capacitance
- Due to cluster size of  $\sim 1.3$ : Cluster charge  $\sim$  charge for individual pixels
- Procedure:
  - Sum histograms for all pixels at the various  $V_{inj}$  steps
  - Again look for best match between cluster charge ToT and the injection ToT
  - Leads to  $V_{inj} = 0.60V \rightarrow C_{inj, calib} \sim 5.9fF$
- Remaining problem: Not detected charge sharing ( $Q < Q_{Thr}$ )

